Enhanced Photoelectrochemical Water Splitting and Photocatalytic Water Oxidation of Cu₂O Nanocube-Loaded BiVO₄ Nanocrystal Heterostructures

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Reducing the fast recombination of photogenerated electron-hole pairs of semiconductor photocatalyst is very important to improve its photocatalysis. In this paper we fabricate Cu₂O nanocube-decorated BiVO₄ nanocrystal (denoted as BiVO₄@Cu₂O nanocrystal@nanocube) heterostructure photocatalyst by coupling *n*-type BiVO₄ with *p*-type Cu₂O. The BiVO₄@Cu₂O nanocrystal@nanocube photocatalysts show superior photocatalytic activities in photoelectrochemical (PEC) activity and photocatalytic water oxidation to BiVO₄ photocatalysts under visible light illumination. The BiVO₄@Cu₂O nanocrystal@nanocube heterostructure electrode achieves the highest photocurrent density of ~ 10 μ A cm⁻² at 0 V



versus Ag/AgCl, 5 times higher than that of BiVO₄ nanocrystal electrode (~ $2 \mu A \text{ cm}^{-2}$). The light induced evolution rate of O₂ generation for BiVO₄@Cu₂O nanocrystal@nanocube heterostructures is as high as 150 µmol h⁻¹100 mg cat⁻¹, more than 3 times higher than that (48 µmol h⁻¹100 mg cat⁻¹) of BiVO₄ nanocrystals. The enhanced photocatalysis activities of the BiVO₄@Cu₂O nanocrystal@nanocube photocatalysts are attributed to the efficient separation of the photoexcited electron-hole pairs caused by inner electronic field (IEF) of *p-n* junction. This study opens up new opportunities in designing photoactive materials with highly enhanced performance for solar energy conversion.

Keywords: nanocrystals, p-n junction heterostructures, photoelectrochemical performance, water oxidation, visible light

1. INTRODUCTION

Recently, numerous studies have demonstrated that semiconductor photocatalytic technique based on solar light is widely considered as one of the most promising ways to provide a sustainable energy source in the future.^[1-3] Semiconductor-based photocatalytic water splitting has been generally considered as one efficient option for economic conversion of solar to chemical energy.^[4-6] Among semiconductor photocatalysts, visible-light-driven semiconductor oxide photocatalysts for photocatalytic water splitting have especially attracted considerable interest in recent years, due to their capability to convert solar energy to chemical energy by direct use of sunlight.^[7-9] In addition, many studies on photocatalytic performance of semiconductor oxide photocatalysts have shown that the conversion efficiency of solar to chemical energy is heavily determined from efficient separation of the photogenerated electron-hole pairs in photocatalyst. However, it has been demonstrated that almost every oxide semiconductor photocatalyst has a high recombination rate of the photoinduced electron-hole pairs.^[10,11] Therefore, considerable attempts have been devoted to addressing this problem through fabricating heterogeneous photocatalysts with efficiently photogenerated electron-hole separation and enhanced photocatalysis activity.

It has been demonstrated that heterogeneous photocatalysts fabricated by combining one semiconductor with two or more than two semiconductors have capability of separating photogenerated electron-hole pairs efficiently, leading to enhanced photocatalysis performance.^[12,13] Especially, heterogeneous photocatalysts constructed by coupling one

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p-type semiconductor with one *n*-type semiconductor are expected to exhibit much high separation efficiency of the photoinduced electron-hole pairs and therefore much higher photocatalytic performance, because the p-n junction in the interface of *p*-type semiconductor and *n*-type semiconductor creates an internal electric field (IEF) from n-type semiconductor to *p*-type semiconductor. Under the effect of the established IEF, the photogenerated electrons and holes migrate to opposite directions, resulting in an efficient separation of the electron-hole pairs and hence a significant enhancement for photocatalytic activity.^[14-16] For instance, it was reported that the heterogeneous p-n junction photocatalyst of n-BiVO₄/p-Co₃O₄ with 0.8 wt.% cobalt showed the significant enhancement for incident-photon-tocurrent efficiencies, 4 times higher than that of n-BiVO₄ under illumination with 420 nm.^[15] The p-n junction ZnO/ ZnS/CdS/CuInS₂ heterostructures formed with *p*-type CuInS₂ and *n*-type ZnO/ZnS/CdS showed remarkable improvement for visible light photoelectrocatalytic water splitting performance to ZnO/ZnS/CdS and ZnO/ZnS films.^[16] These studies demonstrate that the p-n junction semiconductor photocatalyst can be a very good candidate for solar water splitting.

As a *n*-type semiconductor, bismuth vanadate (BiVO₄) with band gap energy of about 2.45 eV is considered as a potentially suitable visible-light photocatalyst towards water oxidation,^[17,18] due to its favorable conduction band (CB) and valence band (VB), and capability to absorb a substantial portion of the visible spectrum.^[19] However, several reports have demonstrated that photoexcited electrons and holes are inclined to rapidly recombination in the body of bare BiVO₄ crystal, significantly lowered the photocatalytic efficiency.^[20,21] Consequently, a key issue for improving the visible-light photocatalytic performance of BiVO₄ photocatalyst is to separate its photogenerated electrons and holes efficiently by constructing heterogeneous photocatalytic system.

In this study, we report the fabrication of heterostructure photocatalyst of p-Cu₂O nanocube-decorated n-BiVO₄ nanocrystals (denoted as BiVO₄@Cu₂O nanocrystal@ nanocube heterostructures) and its enhanced photoel-ectrochemical (PEC) activity and photocatalytic water oxidation under visible light illumination. A working mechanism was proposed to understand the improved separation of the photogenerated electrons and holes, and the enhanced PEC activity and photocatalytic water oxidation of BiVO₄@Cu₂O nanocrystal@nanocube heterostructures.

2. EXPERIMENTAL PROCEDURE

A facilely hydrothermal method has been employed to synthesize BiVO₄ nanocrystals. In a typical synthetic procedure, Bi(NO₃)₃·5H₂O (2.42 g) was dissolved in HNO₃ (2 mL) under constant stirring, followed by adding 7.5 mL high purity water to form a solution (denoted as solution A). Secondly, NH₄VO₃ (0.58 g) was dissolved in NaOH solution (10 mL, 4 M), followed by adding ethylenediaminetetraacetates (EDTA) (1.00 g) to form a solution (denoted as solution B). Finally, solution B was added into solution A drop by drop, and then the pH of the mixture suspension was adjusted to 7 by slowly adding NaOH solution (2 M). The obtained mixture suspension was subsequently sealed in a 50 mL Teflon-lined stainless-steel autoclave, heated at 180 °C for 24 h.

The BiVO₄@Cu₂O nanocrystal@nanocube heterostructures were fabricated by a facile, low cost, and environmentalfriendly polyol process. A typical procedure was given as follows: Cu(CH₃OO)₂·H₂O (80 mg) was dissolved in 50 mL of ethanol (EtOH), then the as-obtained BiVO₄ nanocrystals (300 mg) was added to form suspension mixture under sonication. The suspension mixture was stirred for 6 h and subsequently dried to prepare mixture powder of Cu(CH₃OO)₂·H₂O and BiVO₄. Then mixture powder was then suspended in di-ethylene glycol (DEG) solution (180 mL) under sonication to make Cu²⁺ concentration of 2.5 mM, the solution was transferred into a flask with volume of 250 mL and heated at 180 °C for 2 h in an oil bath under stirring.

X-ray powder diffraction (XRD) patterns were recorded on a Rigaku (Japan) Dmax γA rotation anode X-ray diffractometer equipped with graphite monochromatized Cu-K α radiation ($\lambda = 1.54178$ Å), employing a scanning rate of 0.02 ° s⁻¹ in the 2 θ range from 10 to 80 °. The emission scanning electron microscopy (ESEM) images were taken with a Hitachi S-4800 scanning electron microscope. UV-vis diffuse reflectance spectra (DRS) were recorded on a Lambda 950 UV/vis/NIR spectrophotometer (Perkin-Elmer, USA). X-ray photoelectron spectroscopy (XPS) was carried out on an ESCALAB M KII X-ray photoelectron spectrometer using Mg K α X-rays as the excitation source, the binding energies obtained in the XPS analysis were corrected with reference to C1s (284.6 eV).

For PEC tests, thin films of BiVO₄@Cu₂O nanocrystal@ nanocube heterostructures were prepared on a FTO glass electrode $(1.0 \times 1.0 \text{ cm}^2)$ by drop coating and drying at 60 °C in vacuum condition for 6 h. The measurements were conducted on a three-electrode configuration in a quartz cell. The prepared catalyst working electrode was placed into a cell with a Pt counter electrode and Ag/AgCl reference electrode, respectively. The cell was filled with 0.1 M Na₂SO₄ buffer solution (100 mL and pH 7), and the solution was degassed with N₂ for 30 min before illumination. The light source employed in PEC tests was a 300-W Xenon lamp with an AM 1.5 G filter. The linear sweep voltammograms were operated at 5 mVs⁻¹ in a potential range from 0.0 to 1.0 V versus Ag/AgCl both in dark and under illumination.

The photocatalytic oxidation of water for O₂ evolution was carried out in a closed gas circulation and evacuation system. Briefly, the as-achieved BiVO₄@Cu₂O nanocrystal@nanocube heterostructure catalyst (100 mg) was dispersed in 0.05 M AgNO₃ solution (120 mL) to form a suspension in a Pyrex glass reaction cell. The suspension was degassed, and then was illuminated with a 300 W Xenon lamp ($\lambda > 420$ nm) from the top of the cell. During the reaction, the temperature of the solution was kept at room temperature with cooling water. The amount of O₂ was collected and evaluated by an online gas chromatograph.



Fig. 1. XRD patterns of the pure $BiVO_4$ nanocrystals and $BiVO_4$ (@ Cu_2O nanocrystal (@nanocube heterostructures.

3. RESULTS AND DISCUSSION

The composition and crystal phase of BiVO₄ nanocrystals and BiVO4@Cu2O nanocrystal@nanocube heterostructures was analyzed by XRD as shown in Fig. 1. In the XRD pattern of pure BiVO4 nanocrystals, all diffraction peaks can be easily indexed to those of a monoclinic BiVO₄ cell with lattice parameters of a = 5.195 Å, b = 11.701 Å, c = 5.092 Å and $\beta = 90.38^{\circ}$ (JCPDS No. 14-0668). As for the XRD pattern of the as-achieved BiVO4@Cu2O nanocrystal@ nanocube heterostructures, the dominant diffraction peaks are also from the monoclinic BiVO₄ crystallite as shown in Fig. 1, indicating that there is a small portion of Cu₂O nanocrystals in heterogeneous structures. However, a weak diffraction peak located at about 36.5 ° can be obviously detected as demonstrated in Fig. 1. This peak can be easily assigned to the (111) plane of the Cu₂O crystallite, showing the BiVO₄@Cu₂O nanocrystal@nanocube heterostructures were achieved in the present work.

SEM was employed to evaluate the morphology and size of BiVO₄ nanocrystals and BiVO₄@Cu₂O nanocrystal@ nanocube heterostructures. SEM images of the BiVO₄ nanocrystals reveal that large quantity of plate-like nanocrystals with thickness of about 100 to 400 nm was achieved as shown in Fig. 2 A, B. The surfaces of the BiVO₄ nanocrystals are very smooth and clean as clearly shown in Fig. 2B. After depositing reaction, a large number of Cu₂O nanocubes were assembled on the surfaces of plate-like BiVO₄ nanocrystals as shown in Fig. 2 C, D. Higher



Fig. 2. SEM images of the as-prepared products: (A) and (B) pure $BiVO_4$ nanocrystals with different magnifications, (C) and (D) $BiVO_4@Cu_2O$ nanocrystal@nanocube heterostructures with different magnifications.



Fig. 3. High-resolution XPS spectra of the as-fabricated $BiVO_4@Cu_2O$ nanocrystal@nanocube heterostructures: (A) Bi 4f, (B) V 2p, (C) Cu 2p, and (D) O 1s.

magnification SEM images as presented in Fig. 2D demonstrate that the Cu₂O nanocrystals exhibit cube-like morphology with edge length of about 80 to 100 nm.

XPS has been applied to further analyze the composition and chemical state of elements in BiVO4@Cu2O nanocrystal @nanocube heterostructures. In the XPS spectrum of Bi 4F band as shown in Fig. 3A, two binding energies at 164.2 and 158.9 eV can be indexed to Bi $4f_{5/2}$ and Bi $4f_{7/2}$ bands, respectively. In Fig. 3B, the binding energies located at 524.2 and 516.4 eV can be assigned to V $2p_{1/2}$ and V $2p_{3/2}$ bands, respectively. Figure 3C shows the high-resolution XPS spectrum of Cu 2p band, in which two binding energies at 952.6 and 932.3 eV correspond to Cu $2p_{1/2}$ and Cu $2p_{3/2}$ bands of Cu₂O crystallites, respectively. In addition, an obvious feature of Cu 2p band is that there are three satellites on the high-binding-energy side of the Cu $2p_{3/2}$ peak. These three satellites locate at 934.2, 940.4, and 943.6 eV, which are denoted as I, II and III peaks (Fig. 3C), respectively. The high-resolution XPS spectrum of Cu 2p demonstrates main characteristics of Cu⁺ and the feature of an open 3d⁹ shell of Cu²⁺ state, which is confirmed by shake-up satellite peaks.^[22] Thus the XPS spectrum of Cu 2p indicates the presence of CuO at the surface of Cu₂O nanocrystals. It is worthwhile to note that no CuO phase is detected in the XRD pattern of BiVO₄@Cu₂O nanocrystal@nanocube heterostructures, suggesting the amount of CuO in the heterostructures is

beyond the detection limit of XRD. In the XPS spectrum of O 1s band as shown in Fig. 3D, the binding energies at 529.9 and 531.2 eV (denoted as I and II) are attributed to the O 1s band of lattice oxygen of $Cu_2O^{[23]}$ and $BiVO_4$,^[24] respectively. So, it can be concluded that the Cu element exists in the form of Cu_2O on the surface of $BiVO_4$ @Cu₂O nanocrystal@ nanocube heterostructures.

It has been reported that the DRS is usually applied to evaluate the band edge of the semicondcutors. For a crystalline semiconductor, the equation $\alpha E_{photon} = K(E_{photon} - K(E_{phot$ $(E_g)^{n/2}$ has been widely employed to determine the relationship of band edge and optical absorption, where α , E_{photon}, K and E_{e} are the absorption coefficient, the discrete photo energy, a constant and the band gap energy, respectively.^[25] For the direct and indirect semiconductor, the values of n are 1 and 4, respectively. Figure 4 shows the DRS of BiVO₄ nanocrystals and BiVO4@Cu2O nanocrystal@nanocube heterostructures. As reported in previous literature, monoclinic BiVO₄ is a direct semiconductor. Thus n value is 1 for BiVO₄ crystallite. Because amounts of BiVO₄ nanocrystals are the main constituents in BiVO₄(a)Cu₂O nanocrystal(a) nanocube heterostructures, the value of the band gap energy of the heterostructures also evaluated by the equation $\alpha E_{\text{photon}} = K(E_{\text{photon}} - E_{\text{g}})^{n/2}$ with n value of 1. E_{g} values of the BiVO₄ nanocrystals and BiVO₄@Cu₂O nanocrystal@ nanocube heterostructures are estimated from the plot of



Fig. 4. (A) Diffuse reflectance spectra of $BiVO_4$ nanocrystals and $BiVO_4@Cu_2O$ nanocrystal@nanocube heterostructures. (B) Band gap energy of the as-prepared pure $BiVO_4$ nanocrystals and the as-fabricated $BiVO_4@Cu_2O$ nanocrystal@nanocube heterostructures.

 $(\alpha E_{photon})^2$ vs E_{photon} as shown in Fig. 4B. The absorption edge energies of the BiVO₄ nanocrystals and BiVO₄@Cu₂O nanocrystal@nanocube heterostructures are 2.48 and 2.46 eV, respectively, evaluated by the extrapolated value (the straight line to the χ axis) of E_{photon} at $\alpha = 0$.

To evaluate whether the as-fabricated BiVO4@Cu2O nanocrystal@nanocube heterostructures show enhanced PEC performance under visible illumination, a set of PEC measurements were carried out. Figure 5 shows the chronoamperometric I-t curves of the BiVO₄ nanocrystal and BiVO₄@Cu₂O nanocrystal@nanocube heterostructure electrode, recorded in 0.1 M Na₂SO₄ electrolyte in the dark and under visible light illumination ($\lambda > 420$ nm) at 0 V versus Ag/AgCl. The BiVO4@Cu2O nanocrystal@nanocube heterostructure electrode achieves the highest photocurrent density of 10 μ A cm⁻² at 0 V versus Ag/AgCl, 5 times higher of the photocurrent density for bare BiVO₄ nanocrystal electrode (2 μ A cm⁻²). It has been reported that I-t property obtained by PEC activity can reveal the interfacial generation and separation dynamics of photogenerated charges for semiconductor photocatalyst. A larger photocurrent indicates



Fig. 5. Amperometric *I*-*t* curves at 0 V versus Ag/AgCl under illumination of visible light with wavelength \ge 420 nm with 60 s light on/ off cycles.



Fig. 6. Photocurrent density versus applied potential curves under chopped 300 W Xe lamp irradiation, recorded at 5 mVs⁻¹ and pH = 7 in 0.1 M Na₂SO₄ buffer solution.

higher electrons and holes separation efficiency.^[26] Thus the enhanced photocurrent density on the BiVO₄@Cu₂O nanocrystal@nanocube heterostructure is ascribed to its higher electrons and holes separation efficiency. In addition, when the light was turned off, the residual current (dark current) of Cu₂O nanocube-loaded BiVO₄ nanocrystal photoanode did not approach to zero rapidly, compared to pure BiVO₄ nanocrystal photoanode. This result suggested that Cu₂O nanocube-loaded BiVO₄ nanocrystal heterostructures was able to carry out direct electrochemical redox reaction, as reported in previous literature.^[27]

Figure 6 shows a set of linear sweep voltammagrams (LSV) of BiVO₄ nanocrystal and BiVO₄@Cu₂O nanocrystal @nanocube heterostructure electrodes under visible light illumination, recorded in 0.1 M Na₂SO₄ buffer solution at pH 7 and at 5 mVs⁻¹ in a potential range from 0.0 to 1.0 V versus

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Fig. 7. The amount of oxygen evolution versus visible light ($\lambda > 420 \text{ nm}$) irradiation time through photocatalytic water oxidation by using BiVO₄ and BiVO₄@Cu₂O nanocrystal@nanocube heterostructures in the presence of sacrificial agent AgNO₃.

Ag/AgCl, both in dark and under illumination with a 300 W Xenon lamp (AM 1.5G, 100 mW/cm²). The LSVs clearly demonstrate that the BiVO₄@Cu₂O nanocrystal@nanocube heterostructure photoelectrode exhibits fast light response, due to efficient charge separation and transport through *p-n* junctions. At 0.96 V versus Ag/AgCl, the photocurrent density generated on the pure BiVO₄ nanocrystal photoelectrode is ~ 3.0 μ A cm⁻², while the one on the BiVO₄@Cu₂O nanocrystal@nanocube heterostructure photoelectrode is ~ 22.0 μ A cm⁻², more than 7 times higher than that for pure BiVO₄ nanocrystal photoelectrode. Thus the remarkable photocurrent density enhancement in the LSVs further confirms that the as-constructed BiVO₄@Cu₂O nanocrystal@nanocube heterostructures show enhanced PEC activity, compared to the pure BiVO₄ nanocrystals.

We further study photocatalytic water oxidation for O₂ evolution of BiVO₄@Cu₂O nanocrystal@nanocube heterostructures and BiVO₄ nanocrystals under visible light ($\lambda >$ 420 nm) illumination in the presence of sacrificial electron acceptor AgNO₃. As shown in Fig. 7, the light induced evolution rate of O₂ generation for BiVO₄@Cu₂O nanocrystal @nanocube heterostructures is as high as 150 µmol h⁻¹ 100 mg cat⁻¹, which is more than 3 times higher than that (48 µmol h⁻¹100 mg cat⁻¹) of pure BiVO₄ nanocrystals. This further confirms the high visible-light photocatalytic efficiency of the BiVO₄@Cu₂O nanocrystal@nanocube heterostructures, compared to the pure BiVO₄ nanocrystals.

As is well documented in the previous literature, in the heterostructure formed with p-type and n-type semiconductor, there is a space charge region caused by the opposite direction diffusion of electrons in n-type semiconductor and holes in p-type semiconductor, leading to a p-n junction at the interface of semiconductors and an IEF from n-type

semiconductor to *p*-type semiconductor. The built IEF can significantly separate the photoexcited electrons and holes of the semiconductor heterostructures, leading to enhanced photocatalytic performance. In the present work, Cu₂O is a *p*-type semiconductor with direct band gap of ca. 2.0 eV,^[28] BiVO₄ is a *n*-type semiconductor with a band gap of ca 2.45 eV.^[19,29] Hence the BiVO₄@Cu₂O nanocrystal@nanocube heterostructures are expected to show enhanced PEC activity, compared to pure BiVO₄ nanocrystals.

The understanding of the charge separation process between *p*-type Cu₂O and *n*-type BiVO₄ is very important to elucidate the enhanced photocatalysis performance and PEC activity of the BiVO₄@Cu₂O nanocrystal@nanocube heterostructures. Thus the construction of an energy diagram between *p*-type Cu₂O and *n*-type BiVO₄ by their CB and VB positions is a key issue to illustrate the transfer and separation of the photoexcited electrons and holes in the system. As reported in the previous literature, the CB and VB positions of a semiconductor can be calculated by the following equations:^[30]

$$E_{VB} = X - E^e + 0.5E_g \tag{1}$$

$$E_{CB} = E_{VB} - E_g \tag{2}$$

Wherein, *X*, E^e and E_g are the absolute electronegativity of the semiconductor, the energy of free electrons on the hydrogen scale (ca. 4.5 eV) and the band gap of the semiconductor, respectively. The X values for Cu₂O and BiVO₄ are ca. 4.84 eV^[31] and 6.035 eV,^[32] respectively. The E_g values for Cu₂O and BiVO₄ are ca. 2.0 eV^[29] and 2.45 eV,^[19] respectively. The calculated VB and CB values of *p*-type Cu₂O are 1.3 and -0.7 eV, respectively. While the VB and CB values of *n*-type BiVO₄ are calculated to be 2.76 and 0.31 eV, respectively.

According to the VB and CB values of *p*-type Cu₂O and *n*-type BiVO₄ semiconductor, before contact of Cu₂O and



Fig. 8. Schematic energy diagram and charge transfer between p-type Cu₂O and n-type BiVO₄: (A) before contact and (B) after contact to the formation of the p-n junction.



Fig. 9. The proposed mechanism of photocatalytic water oxidation by BiVO₄@Cu₂O nanocrystal@nanocube heterostructures in the presence of sacrificial agent AgNO₃.

BiVO₄, the Fermi level of p-type Cu₂O is lower than that of *n*-type BiVO₄, and the CB edge of *p*-type Cu_2O is higher than that of *n*-type BiVO₄ as demonstrated in Fig. 8A. After contact of Cu₂O and BiVO₄, with the Fermi level move up and down of p-type Cu₂O and n-type BiVO₄, respectively, an equilibrium state is established in p-type Cu₂O/n-type BiVO₄ heterostructure as shown in Fig. 8B. Meanwhile, the whole energy band of Cu₂O is raised up with the move up of its Fermi level, while whole energy band of BiVO4 is descended with the move down of its Fermi level. As a result, the CB edge of Cu₂O is much higher than that of BiVO₄, while the VB of BiVO₄ is much lower than that of Cu₂O, leading to an IEF from n-type BiVO₄ to p-type Cu₂O at the equilibrium as shown in Fig. 8B. The energy-band schematic diagram of the BiVO4@Cu2O nanocrystal@ nanocube heterostructure is shown in Fig. 8.

In the as-constructed BiVO4@Cu2O nanocrystal@nanocube heterostructure, both Cu₂O and BiVO₄ can be excited by visible-light to generate electrons and holes. As demonstrated in the above energy-band schematic diagram (Fig. 8B), when both Cu₂O and BiVO₄ are irradiated with visible light, the photoexcited electrons on the CB of the *p*-type Cu₂O can transfer to that of the *n*-type BiVO₄, and holes remain in the VB of *p*-type Cu₂O, while the photoinduced holes on the VB of *n*-type BiVO₄ can migrate to that of *p*-type Cu_2O , the photogenerated electrons remain in the CB of *n*-type BiVO₄ as shown in Fig. 8B. In addition, the migration of the photoexcited electrons and holes in the BiVO4@Cu2O nanocrystal@nanocube heterostructure can be significantly promoted by the established IEF, which is from *n*-type BiVO₄ to *p*-type Cu₂O. Hence the photoexcited electrons and holes in the BiVO4@Cu2O nanocrystal@nanocube heterostructure can be separated efficiently by the p-njunction formed between the *p*-type Cu₂O and *n*-type BiVO₄

interface, and the recombination of electron-hole pairs can be significantly reduced.

The effective separation of photogenerated electrons and holes in the BiVO4@Cu2O nanocrystal@nanocube heterostructure are responsible for its improved PEC performance for water oxidation. When the BiVO₄@Cu₂O nanocrystal@ nanocube heterostructure on the working electrode was irradiated by visible light, the photoexcited electrons migrate to the counter electrode and holes remain in the working electrode, resulting in the generation of photocurrent. As analyzed above, the IEF built in the BiVO4@Cu2O nanocrystal@nanocube heterostructure can accelerate the transfer of photoexcited electrons from *p*-type Cu₂O to *n*type BiVO₄ and the migration of the photoexcited holes from *n*-type BiVO₄ to *p*-type Cu₂O, causing significantly enhanced amount of the electrons in the counter electrode, and resulting in the photocurrent enhancement to pure BiVO₄.

According to the energy alignment of the BiVO₄@Cu₂O nanocrystal@nanocube heterostructure as shown in Fig. 8B, for the photogenerated electrons and holes in *p*-type Cu₂O, the electrons on the CB of Cu₂O will transfer to that of BiVO₄, while holes remain on the VB of Cu₂O. For the photogenerated electrons and holes in n-type BiVO₄, the holes on the VB of BiVO₄ will transfer to that of Cu₂O, while the electrons remain on the CB of BiVO₄, leading to the efficient separation of the photogenerated electrons and holes in heterostructure, and thereby increasing their lifetime.^[33] Increasing lifetime of photogenerated charges is very important to photocatalytic water oxidation because it is slow multielectron processes.^[34] When the photoexcited electrons on the surface of *n*-type BiVO₄ reduce the adsorbed Ag^+ to Ag^0 , the holes on the surface of *n*-type Cu₂O will have relatively longer lifetime to carry out the fourelectron process of H₂O oxidation to O₂. The proposed mechanism of photocatalytic water oxidation by $BiVO_4(a)$ Cu₂O nanocrystal@nanocube heterostructures in the presence of sacrificial agent AgNO₃ is illustrated in Fig. 9.

4. CONCLUSIONS

We report that the appropriate energy level match between *p*-type Cu₂O nanocubes and *n*-type BiVO₄ nanocrystals makes it to establish *p*-*n* junction at the interface, prompting the highly efficient separation of the photogenerated electronhole pairs and subsequently leading to the remarkably enhanced photocatalysis activity. The as-constructed *p*-*n* junction BiVO₄@Cu₂O nanocrystal@nanocube heterostructure photocatalytic water oxidation under visible irradiation. The BiVO₄@Cu₂O nanocrystal@nanocube heterostructure electrode achieves the highest photocurrent density of 10 μ A cm⁻² at 0 V versus Ag/AgCl, 5 times higher than that of bare

BiVO₄ nanocrystal electrode (2 μ A cm⁻²). The photocurrent density generated on BiVO₄@Cu₂O nanocrystal@nanocube heterostructure electrode is up to 22 μ A cm⁻², more than 7 times higher than that (3.0 μ A cm⁻²) of pure BiVO₄ nanocrystal electrode at 0.96 V versus Ag/AgCl. The light induced evolution rate of O₂ generation for BiVO₄@Cu₂O nanocrystal@nanocube heterostructures is as high as 150 μ mol h⁻¹100 mg cat⁻¹, which is more than 3 times higher than that (48 μ mol h⁻¹100 mg cat⁻¹) of pure BiVO₄ nanocrystals. We believe that this study can have considerable impact on the future development of highly efficient visiblelight *p-n* junction photocatalysts with highly enhanced performance for solar energy conversion.

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